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| Notice of References Cited | Application/Control No. 10/726,701 | | Applicant(s)/Patent Under Reexamination HATORI ET AL. | |
| | Examiner BRENDAN MCCOMMAS | | Art Unit 2625 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-2002/0093680 | 07-2002 | Tanaka, Keisuke | 358/1.15 |
| * | B | US-6,348,971 | 02-2002 | Owa et al. | 358/1.15 |
| * | C | US-6,956,665 | 10-2005 | Miyahara, Nobuaki | 358/1.15 |
| * | D | US-6,924,906 | 08-2005 | Schwier et al. | 358/1.6 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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